

HEIWA.022AUS

PATENT

## IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

Applicant	:	Yoshihiro Hashimoto	)	Group Art Unit
			)	
Serial No.	:	New Application	)	
			)	
Filed	:	Concurrently Herewith	)	
			)	
For	:	DIFFERENTIAL VOLTAGE	)	
		MEASURING APPARATUS AND	)	
		SEMICONDUCTOR TESTING	)	
		APPARATUS	)	
			)	
Examiner	:	Unknown	)	
			)	

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PRELIMINARY AMENDMENT

Hon. Commissioner  
of Patents and Trademarks  
Alexandria, VA 22313-1450

Dear Sir:

This amendment is submitted for the above-identified patent application for correcting the forms of the claims. Please make the following changes.